

Report No.: SZEM180400289801

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## TEST REPORT

Application No: SZEM1804002898RG

Applicant:Huawei Technologies Co., Ltd.Manufacturer:Huawei Technologies Co., Ltd.Factory:Huawei Technologies Co., Ltd.

Product Name: Smart Phone

Model No.(EUT): ANE-LX2J/HWV32

Trade Mark: HUAWEI
FCC ID: QISANE-LX2J
Standards: 47 CFR Part 2

47 CFR Part 90S

47 CFR Part 22 subpart H

Test Method: FCC KDB 971168 D01 Power Meas License Digital Systems v03

TIA-603-E 2016

**Date of Receipt:** 2018-04-10

**Date of Test:** 2018-04-12 to 2018-04-19

**Date of Issue:** 2018-04-19

Test Result: PASS \*

Authorized Signature:

Derole yang

Derek Yang

Wireless Laboratory Manager

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<sup>\*</sup> In the configuration tested, the EUT detailed in this report complied with the standards specified above.



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## 2 Version

|                                      | Revision Record |            |  |          |  |
|--------------------------------------|-----------------|------------|--|----------|--|
| Version Chapter Date Modifier Remark |                 |            |  |          |  |
| 01                                   |                 | 2018-04-26 |  | Original |  |
|                                      |                 |            |  |          |  |
|                                      |                 |            |  |          |  |

| Authorized for issue by: |                             |            |
|--------------------------|-----------------------------|------------|
| Tested By                | Mike Mu                     | 2018-04-26 |
|                          | (Mike Hu) /Project Engineer | Date       |
| Checked By               | J. Mung                     | 2018-04-26 |
|                          | (Jim Huang) /Reviewer       | Date       |



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## 3 Test Summary for LTE Band 26 (814MHz-824 MHz)

| Test Item   | FCC<br>Rule No.              | Requirements  | Test Result                | Verdict |
|---|------------------------------|---|----------------------------|---------|
| Effective<br>(Isotropic)<br>Radiated Power<br>Output Data | §2.1046,<br>§90.635          | ERP≤7W<br>BAND 26(814-824)}   | Section 1 of<br>Appendix B | PASS    |
| Peak-Average<br>Ratio                                     | N/A                          | ≤13dB   | Section 2 of<br>Appendix B | PASS    |
| Modulation<br>Characteristics                             | §2.1047                      | Digital modulation  | Section 3 of<br>Appendix B | PASS    |
| Bandwidth   | §2.1049(h),                  | OBW:No limit EBW: No limit  | Section 4 of<br>Appendix B | PASS    |
| Band Edge<br>Compliance                                   | §2.1051,<br>§90.691,         | ≤ -13dBm  | Section 5 of<br>Appendix B | PASS    |
| Emission Mask   | §2.1051<br>§ 90.210          | For any frequency removed from the EA licensee's frequency block by up to and including 37.5 kHz, the power of any emission shall be attenuated below the transmitter power (P) in watts by at least 116 Log10(f/6.1) decibels or 50+10Log10(P) decibels or 80 decibels, whichever is the lesser attenuation, where f is the frequency removed from the center of the outer channel in the block in kilohertz and where f is greater than 12.5 kHz. | Section 6 of<br>Appendix B | PASS    |
| Spurious emissions at antenna terminals                   | §2.1051,<br>§90.691          | ≤ -13dBm  | Section 7 of<br>Appendix B | PASS    |
| Field strength of spurious radiation                      | §2.1053,<br>§90.691(a)(1)(2) | ≤ -13dBm  | Section 8 of<br>Appendix B | PASS    |
| Frequency stability                                       | §2.1055,(a)<br>§90.213       | ≤ ±2.5ppm.  | Section 9 of<br>Appendix B | PASS    |



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## 4 Test Summary for LTE Band 26 (824 MHz -849 MHz)

| Test Item   | FCC<br>Rule No.         | Requirements                  | Test Result                | Verdict |
|---|-------------------------|-------------------------------|----------------------------|---------|
| Effective<br>(Isotropic)<br>Radiated Power<br>Output Data | §2.1046,<br>§22.913,    | ERP≤7W<br>BAND 26(824-849)}   | Section 1 of<br>Appendix B | PASS    |
| Peak-Average<br>Ratio                                     | RSS 132,5.4             | ≤13dB                         | Section 2 of<br>Appendix B | PASS    |
| Modulation<br>Characteristics                             | §2.1047                 | Digital modulation            | Section 3 of<br>Appendix B | PASS    |
| Bandwidth   | §2.1049(h),<br>§22.917, | OBW:No limit<br>EBW: No limit | Section 4 of<br>Appendix B | PASS    |
| Band Edge<br>Compliance                                   | §2.1051,<br>§22.917,    | ≤ -13dBm                      | Section 5 of<br>Appendix B | PASS    |
| Spurious<br>emissions at<br>antenna terminals             | §2.1051,<br>§22.917,    | ≤ -13dBm                      | Section 6 of<br>Appendix B | PASS    |
| Field strength of spurious radiation                      | §2.1053,<br>§22.917,    | ≤ -13dBm                      | Section 7 of<br>Appendix B | PASS    |
| Frequency stability                                       | §2.1055,<br>§22.355,    | ≤ ±2.5ppm.                    | Section 8 of<br>Appendix B | PASS    |



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#### 5 General Information

#### 5.1 Client Information

| Applicant:               | Huawei Technologies Co., Ltd.   |
|--------------------------|---|
| Address of Applicant:    | Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C |
| Manufacturer:            | Huawei Technologies Co., Ltd.   |
| Address of Manufacturer: | Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C |
| Factory:                 | Huawei Technologies Co., Ltd.   |
| Address of Factory:      | Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C |

### 5.2 General Description of EUT

| Product Name: | Smart Phone         |
|---------------|---------------------|
| Model No.:    | ANE-LX2J/HWV32      |
| Trade Mark:   | HUAWEI              |
| Sample Type:  | Portable production |
| Antenna Type: | PIFA Antenna        |
| Antenna Gain: | LTE B26: -2.9dBi    |

#### 5.3 Test Mode

| Test Mode | Test Modes Description       |  |
|-----------|------------------------------|--|
| LTE/TM1   | LTE system, QPSK modulation  |  |
| LTE/TM2   | LTE system, 16QAM modulation |  |

NOTE: The test mode(s) are selected according to relevant radio technology specifications.

#### 5.4 Test Environment

| Environment Parameter | Selected Values During Tests |         |
|-----------------------|------------------------------|---------|
| Relative Humidity     | 52%                          |         |
| Atmospheric Pressure: |                              | 1015MPa |
| Temperature           | TN                           | 25 ℃    |
|                       | VL                           | 3.6V    |
| Voltage:              | VN                           | 3.8V    |
|                       | VH                           | 4.35V   |

NOTE: VL= lower extreme test voltage

VN= nominal voltage

VH= upper extreme test voltage

TN= normal temperature



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### 5.5 Test Frequency

| Test Mode BandWidth |               | TX / RX | Test Channel  |               |               |
|---------------------|---------------|---------|---------------|---------------|---------------|
| rest Mode           | Danavian      | I       | Low (L)       | Middle (M)    | High (H)      |
|                     |               | TV      | Channel 26697 | Channel 26740 | Channel 26783 |
|                     | 4 4 1 4 1 1 - | TX      | 814.7 MHz     | 819 MHz       | 823.3MHz      |
|                     | 1.4MHz        | DV      | Channel 8697  | Channel 8740  | Channel 8783  |
|                     |               | RX      | 859.7 MHz     | 864 MHz       | 868.3 MHz     |
|                     |               | TX      | Channel 26705 | Channel 26740 | Channel 26775 |
|                     | 3MHz          | 1.8     | 815.5 MHz     | 819 MHz       | 822.5 MHz     |
|                     | 3IVITZ        | DV      | Channel 8705  | Channel 8740  | Channel 8775  |
| LTE BAND26          |               | RX      | 860.5 MHz     | 864 MHz       | 867.5 MHz     |
| (814-824)           |               | TX      | Channel 26715 | Channel 26740 | Channel 26765 |
|                     | ENALL-        | 1.      | 816.5 MHz     | 819 MHz       | 821.5 MHz     |
|                     | 5MHz          | RX      | Channel 8715  | Channel 8740  | Channel 8765  |
|                     |               | n.      | 861.5 MHz     | 864 MHz       | 866.5 MHz     |
|                     |               | TX      | /             | Channel 26740 | /             |
|                     | 101411-       | 1.7     | /             | 819 MHz       | /             |
|                     | 10MHz         | DV      | /             | Channel 8740  | /             |
|                     |               | RX      | /             | 864 MHz       | /             |
|                     | 1.4MHz        | TX      | Channel 26797 | Channel 26915 | Channel 27033 |
|                     |               |         | 824.7 MHz     | 836.5 MHz     | 848.3 MHz     |
|                     |               | RX      | Channel 8697  | Channel 8915  | Channel 9033  |
|                     |               |         | 859.7 MHz     | 881.5 MHz     | 893.3 MHz     |
|                     |               | TX      | Channel 26805 | Channel 26915 | Channel 27025 |
|                     | 3MHz          |         | 825.5 MHz     | 836.5 MHz     | 847.5 MHz     |
|                     | SIVITZ        | RX      | Channel 8805  | Channel 8915  | Channel 9025  |
|                     |               |         | 860.5 MHz     | 881.5 MHz     | 892.5 MHz     |
|                     |               | TV      | Channel 26815 | Channel 26915 | Channel 27015 |
| LTE BAND26          | 5MHz          | TX      | 826.5 MHz     | 836.5 MHz     | 846.5 MHz     |
| (824-849)           | SIVITZ        | RX      | Channel 8815  | Channel 8915  | Channel 9015  |
|                     |               | ΠΛ      | 871.5 MHz     | 881.5 MHz     | 891.5 MHz     |
|                     |               | TX      | Channel 26840 | Channel 26915 | Channel 26990 |
|                     | 10MHz         | 17      | 829 MHz       | 836.5 MHz     | 844 MHz       |
|                     | TOWINZ        | DV      | Channel 8840  | Channel 8915  | Channel 8990  |
|                     |               | RX      | 874 MHz       | 881.5 MHz     | 889 MHz       |
|                     |               | TV      | Channel 26865 | Channel 26915 | Channel 26965 |
|                     | 15114-        | TX      | 831.5 MHz     | 836.5 MHz     | 841.5 MHz     |
|                     | 15MHz -       | DΥ      | Channel 8865  | Channel 8915  | Channel 8965  |
|                     |               | RX      | 876.5 MHz     | 881.5 MHz     | 886.5 MHz     |



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#### 5.6 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen Branch

No. 1 Workshop, M-10, Middle Section, Science & Technology Park, Shenzhen, Guangdong, China. 518057.

Tel: +86 755 2601 2053 Fax: +86 755 2671 0594

No tests were sub-contracted.

### 5.7 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

#### CNAS (No. CNAS L2929)

CNAS has accredited SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

#### A2LA (Certificate No. 3816.01)

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

#### VCCI

The 10m Semi-anechoic chamber and Shielded Room of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-823, R-4188, T-1153 and C-2383 respectively.

#### • FCC -Designation Number: CN1178

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized as an accredited testing laboratory.

Designation Number: CN1178. Test Firm Registration Number: 406779.

#### • Industry Canada (IC)

Two 3m Semi-anechoic chambers and the 10m Semi-anechoic chamber of SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab have been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 4620C-1, 4620C-2, 4620C-3.

#### 5.8 Deviation from Standards

None.

#### 5.9 Abnormalities from Standard Conditions

None.



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## 5.10 Other Information Requested by the Customer

None.

### 5.11 Technical Specification

| Characteristics           | Description                   |                                   |  |
|---------------------------|-------------------------------|-----------------------------------|--|
| Radio System Type         | □ LTE                         |                                   |  |
|                           | LTE band 26(814-824)          | Transmission (TX): 814 to 824 MHz |  |
| Supported Fraguency Pange | LTE Dalla 20(014-024)         | Receiving (RX): 859 to 869 MHz    |  |
| Supported Frequency Range | LTE la a a d00/004 040        | Transmission (TX): 824 to 849 MHz |  |
|                           | LTE band26(824-849)           | Receiving (RX): 869 to 894 MHz    |  |
| Target TX Output Power    | LTE band 26(814-824): 23.5dBm |                                   |  |
| raiget in Output Fower    | LTE band 26(824-849): 23.5dBm |                                   |  |
|                           | LTE band26(814-824)           | ⊠1.4 MHz;⊠3 MHz; ⊠5 MHz; ⊠10 MHz  |  |
| Supported Bandwidth       | LTE hand00(004.040)           | ⊠1.4 MHz;⊠3 MHz; ⊠5 MHz; ⊠10 MHz  |  |
|                           | LTE band26(824-849)           | ⊠15 MHz                           |  |

| Characteristics  | Description         |                  |  |
|--|---------------------|------------------|--|
|  | LTE band26(814-824) | 1M10G7D;1M11W7D; |  |
|  |                     | 2M69G7D;2M69W7D; |  |
| Designation of Emissions (Note: the necessary bandwidth of which is the worst value from the measured occupied bandwidths for each type of channel bandwidth configuration.) |                     | 4M48G7D;4M48W7D; |  |
|  |                     | 8M93G7D;8M93W7D; |  |
|  | LTE band26(824-849) | 1M10G7D;1M10W7D; |  |
|  |                     | 2M69G7D;2M69W7D; |  |
|  |                     | 4M49G7D;4M49W7D; |  |
|  |                     | 8M95G7D;8M95W7D; |  |
|  |                     | 13M6G7D;13M6W7D; |  |



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### 6 Description of Tests

### **6.1 Conducted Output Power**

Measurement Procedure: FCC KDB 971168 D01 Power Meas License Digital Systems v03

The transmitter output was connected to a calibrated coaxial cable, attenuator and power meter, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The power output at the transmitter antenna port was determined by adding the value of the cable insertion loss to the power reading. The tests were performed at three frequencies (low channel, middle channel and high channel) and on the highest power levels, which can be setup on the transmitters.

Note: Reference test setup 1

### 6.2 Effective (Isotropic) Radiated Power of Transmitter

Measurement Procedure: FCC KDB 971168 D01 Power Meas License Digital Systems v03

#### Below 1GHz test procedure as below:

- 1). The EUT was powered ON and placed on a 1.5m high table in the chamber. The antenna of the transmitter was extended to its maximum length.
- 2). The disturbance of the transmitter was maximized on the test receiver display by raising and lowering from 1m to 4m the receive antenna and by rotating through 360° the turntable. After the fundamental emission was maximized, a field strength measurement was made.
- 3). Steps 1) and 2) were performed with the EUT and the receive antenna in both vertical and horizontal polarization.
- 4). The transmitter was then removed and replaced with another antenna. The center of the antenna was approximately at the same location as the center of the transmitter.
- 5). A signal at the disturbance was fed to the substitution antenna by means of a non-radiating cable. With both the substitution and the receive antennas horizontally polarized, the receive antenna was raised and lowered to obtain a maximum reading at the test receiver. The level of the signal generator was adjusted until the measured field strength level in step 2) is obtained for this set of conditions.
- 6). The output power into the substitution antenna was then measured.
- 7). Steps 5) and 6) were repeated with both antennas polarized.
- 8). Calculate power in dBm by the following formula:

ERP (dBm) = Pg(dBm) - cable loss (dB) + antenna gain (dBd)

Where

Pg is the generator output power into the substitution antenna.

#### Above 1GHz test procedure as below:

- 1). Different between above is the test site, change from Semi- Anechoic Chamber to fully Anechoic Chamber
- 2). Calculate power in dBm by the following formula:

EIRP(dBm) = Pg(dBm) - cable loss (dB) + antenna gain (dBi)

EIRP=ERP+2.15dB

Where: Pg is the generator output power into the substitution antenna.

3). Test the EUT in the lowest channel, the middle channel the Highest channel



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4). The radiation measurements are performed in X, Y, Z axis positioning. And found the X axis positioning which it is worse case, Only the test worst case mode is recorded in the report.

5). Repeat above procedures until all frequencies measured was complete.

Note: Reference test setup 2

### 6.3 Occupied Bandwidth

Measurement Procedure: FCC KDB 971168 D01 Power Meas License Digital Systems v03

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyser, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel, middle channel and high channel). The span of the analyzer shall be set to capture all products of the modulation process, including the emission skirts. The resolution bandwidth shall be set to as close to 1 percent of the selected span as is possible without being below 1 percent. The video bandwidth shall be set to 3 times the resolution bandwidth. Video averaging is not permitted. Where practical, a sampling detector shall be used since a peak or, peak hold, may produce a wider bandwidth than actual. The trace data points are recovered and are directly summed in linear terms. The recovered amplitude data points, beginning at the lowest frequency, are placed in a running sum until 0.5 percent of the total is reached and that frequency recorded. The process is repeated for the highest frequency data points. This frequency is recorded. The span between the two recorded frequencies is the occupied bandwidth.

Note: Reference test setup 1

### 6.4 Band Edge at Antenna Terminals

Measurement Procedure: FCC KDB 971168 D01 Power Meas License Digital Systems v03

The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyser, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel and high channel).in the 1MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of 100kHz or 1% of the emission bandwidth of the fundamental emission of the transmitter may be employed. The EUT emission bandwidth is measured as the width of the signal between two points, outside of which all emission are attenuated at least 26dB below the transmitter power. The video bandwidth of the spectrum analyzer was set at thrice the resolution bandwidth. Detector Mode was set to peak or peak hold power.

Note: Reference test setup 1

#### 6.5 Emission Mask

Measurement Procedure: FCC KDB 971168 D01 Power Meas License Digital Systems v03

- 1. All measurements were done at low and high operational frequency range.
- 2. Set RBW=1% of 26dBc bandwidth, VBW=3 X RBW, detector=RMS, Sweep time = Auto.
- 3. Record the max trace plot into the test report.

### 6.6 Spurious And Harmonic Emissions at Antenna Terminal

Measurement Procedure: FCC KDB 971168 D01 Power Meas License Digital Systems v03

The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyzer, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel and high channel). The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency

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generated in the equipment up to a frequency including its 10th harmonic. On any frequency outside a licensee's frequency block, the power of any emission shall be attenuated below the transmitter power (P) by at least 43 + 10 log(P) dB. Compliance with these provisions is based on the use of measurement instrumentation employing a resolution bandwidth of 1 MHz or greater. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

Note: Reference test setup 1

### 6.7 Peak-Average Ratio

Measurement Procedure: FCC KDB 971168 D01 Power Meas License Digital Systems v03

A peak to average ratio measurement is performed at the conducted port of the EUT. For WCDMA signals, the spectrum analyzers Complementary Cumulative Distribution Function (CCDF) measurement profile is used to determine the largest deviation between the average and the peak power of the EUT in a given bandwidth. The CCDF curve shows how much time the peak waveform spends at or above a given average power level. The percent of time the signal spends at or above the level defines the probability for that particular power level. For GSM signals, an average and a peak trace are used on a spectrum analyzer to determine the largest deviation between the average and the peak power of the EUT in a bandwidth greater than the emission bandwidth. The traces are generated with the spectrum analyzer set to zero span mode.

Note: Reference test setup 1

### 6.8 Field Strength of Spurious Radiation

Measurement Procedure: FCC KDB 971168 D01 Power Meas License Digital Systems v03

#### Below 1GHz test procedure as below:

- 1). The EUT was powered ON and placed on a 150cm high table in the chamber. The antenna of the transmitter was extended to its maximum length.
- 2). The disturbance of the transmitter was maximized on the test receiver display by raising and lowering from 1m to 4m (for the test frequency of below 30MHz, the antenna was tuned to heights 1 meter) the receive antenna and by rotating through 360° the turntable. After the fundamental emission was maximized, a field strength measurement was made.
- 3). Steps 1) and 2) were performed with the EUT and the receive antenna in both vertical and horizontal polarization.
- 4). The transmitter was then removed and replaced with another antenna. The center of the antenna was approximately at the same location as the center of the transmitter.
- 5). A signal at the disturbance was fed to the substitution antenna by means of a non-radiating cable. With both the substitution and the receive antennas horizontally polarized, the receive antenna was raised and lowered to obtain a maximum reading at the test receiver. The level of the signal generator was adjusted until the measured field strength level in step 2) is obtained for this set of conditions.
- 6). The output power into the substitution antenna was then measured.
- 7). Steps 5) and 6) were repeated with both antennas polarized.
- 8) Calculate power in dBm by the following formula:

ERP(dBm) = Pg(dBm) - cable loss (dB) + antenna gain (dBd)

Where:

Pd is the dipole equivalent power, Pg is the generator output into the substitution antenna, and the antenna gain is the gain of the substitute antenna used relative to either a half-wave dipole (dBd) or an isotropic source (dBi). The substitute level is equal to Pg [dBm] – cable loss [dB]. The calculated Pd levels are then

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compared to the absolute spurious emission limit of -13dBm which is equivalent to the required minimum attenuation of 43 + 10log10(Power [Watts]).

#### Above 1GHz test procedure as below:

- 1) Different between above is the test site, change from Semi- Anechoic Chamber to fully Anechoic Chamber
- 2) Calculate power in dBm by the following formula:

EIRP(dBm) = Pg(dBm) - cable loss (dB) + antenna gain (dBi) EIRP=ERP+2.15dB

Where:

Pg is the generator output power into the substitution antenna.

- 3. Test the EUT in the lowest channel, the middle channel the Highest channel
- 4. The radiation measurements are performed in X, Y, Z axis positioning. And found the X axis positioning which it is worse case, Only the test worst case mode is recorded in the report.
- 5. Repeat above procedures until all frequencies measured was complete

Note: Reference test setup 3

### 6.9 Frequency Stability / Temperature Variation

Measurement Procedure:

Frequency stability testing is performed in accordance with the guidelines of FCC KDB 971168 D01 Power Meas License Digital Systems v03

- . The frequency stability of the transmitter is measured by:
- a.) **Temperature:** The temperature is varied from -30 °C to +50 °C in 10 °C increments using an environmental chamber.
- b.) **Primary Supply Voltage:** The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.

Specification – The frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block. The frequency stability of the transmitter shall be maintained within  $\pm 0.00025\%$  ( $\pm 2.5$  ppm ) of the center frequency.

#### **Time Period and Procedure:**

- 1. The carrier frequency of the transmitter is measured at room temperature (20 °C to provide a reference).
- 2. The equipment is turned on in a "standby" condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
- 3. Frequency measurements are made at 10 ℃ intervals ranging from -30 ℃ to +50 ℃. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

Note: Reference test setup 4

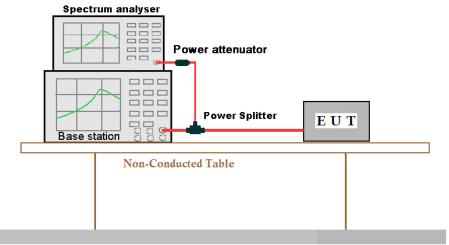


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### 6.10 Test Setups

#### 6.10.1 Test Setup 1



**Ground Reference Plane** 

#### 6.10.2 Test Setup 2

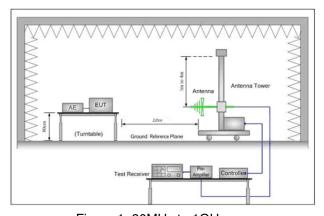
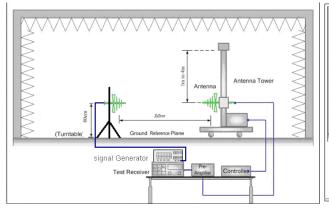
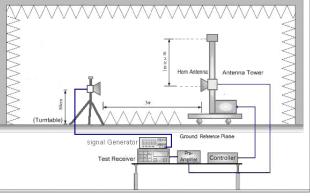


Figure 1. 30MHz to 1GHz

Figure 2. above 1GHz





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Figure 1. 30MHz to 1GHz

Figure 2. above 1GHz

### 6.10.3 Test Setup 3

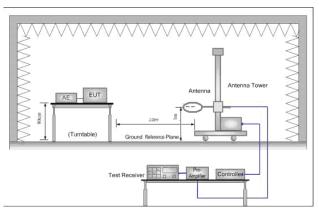


Figure 1. Below 30MHz

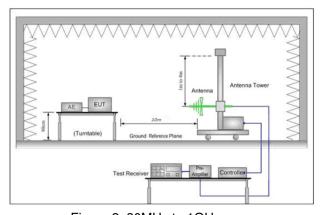


Figure 2. 30MHz to 1GHz

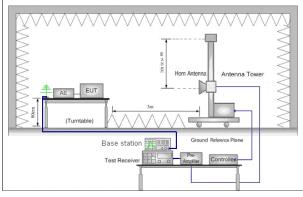


Figure 3. above 1GHz

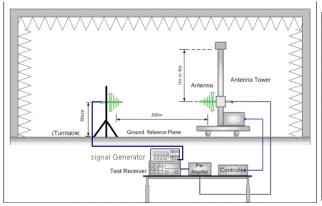


Figure 2. 30MHz to 1GHz

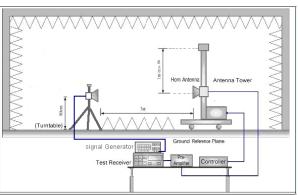


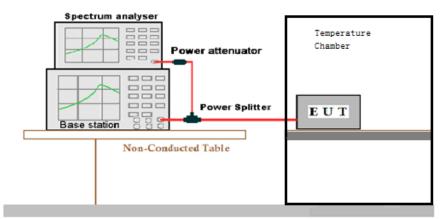
Figure 3. above 1GHz



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#### 6.10.4 Test Setup 4



Ground Reference Plane



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### **6.11 Test Conditions**

| Transmit Output Power Total  Average Power Total  Average Power Total  Fest Setup Test Setup 1  RF Channels (TX) L, M, H (L= low channel, M= middle channel, H- high channel)  Test Mode LTE/TM1;LTE/TM2;  Test Setup Test Setup 1  RF Channels (TX) L, M, H (L= low channel, M= middle channel, H- high channel)  Test Mode LTE/TM1;LTE/TM2;  Test Mode LTE/TM1;LTE/TM2;  Test Mode LTE/TM1;LTE/TM2;  Test Setup Test Setup 1  RF Channels (TX) L, M, H (L= low channel, M= middle channel, H- high channel)  Test Mode LTE/TM1;LTE/TM2;  Test Setup Test Setup 1  RF Channels (TX) L, M, H (L= low channel, M= middle channel, H- high channel)  Test Mode LTE/TM1;LTE/TM2;  Test Setup Test Setup 1  RF Channels (TX) M (M= middle channe)  Test Setup Test Setup 1  RF Channels (TX) M (M= middle channe)  Test Setup Test Setup 1  Test Setup Test Setup 1  RF Channels (TX) L, M, H (L= low channel, M= middle channel, H- high channel)  Test Mode LTE/TM1;LTE/TM2;  Test Setup Test Setup 1  RF Channels (TX) L, M, H (L= low channel, M= middle channel, H- high channel)  Test Setup Test Setup 1  RF Channels (TX) L, M, H (L= low channel, M= middle channel, H- high channel)  Test Setup Test Setup 1  RF Channels (TX) L, M, H (L= low channel, M= middle channel, H- high channel)  Test Setup Test Setup 1  RF Channels (TX) L, M, H (L= low channel, M= middle channel, H- high channel)  Test Setup Test Setup 1  RF Channels (TX) L, M, H (L= low channel, M= middle channel, H- high channel)  Test Setup Test Setup 1  RF Channels (TX) L, M, H (L= low channel, M= middle channel, H- high channel)  Test Setup Test Setup 1  RF Channels (TX) L, M, H (L= low channel, M= middle channel, H- high channel)  Test Setup Test Setup 1  RF Channels (TX) L, M, H (L= low channel, M= middle channel, H- high channel)  Test Mode LTE/TM1;LTE/TM2;  Test Mode LTE/TM1;LTE/TM2;  Test Setup Test Setup 1  RF Channels (TX) L, M, H (L= low channel, H | Test Case                                 |                 | Test Conditions  |   |  |  |
|--|---|-----------------|------------------|---|--|--|
| Average Power, Total  RF Channels (TX)  Test Mode  LTE/TM1;LTE/TM2;  Test Mode  LTE/TM1;LTE/TM2;  Test Mode  LTE/TM1;LTE/TM2;  Test Setup  Test Setup  Test Setup 1  RF Channels (TX)  Test Mode  LTE/TM1;LTE/TM2;  Test Setup 1  Test Setup 1  Test Mode  LTE/TM1;LTE/TM2;  Test Setup 1  Test Setup 1  Test Mode  LTE/TM1;LTE/TM2;  Test Setup 1  Test Setup 1  Test Setup 1  RF Channels (TX)  Test Setup 1  Test Setup 1  RF Channels (TX)  Test Setup 1  RF Channels (TX)  Test Setup 1  RF Channels (TX)  Test Setup 1  Test Setup 1  RF Channels (TX)  Test Setup 1  Test S | Transmit                                  |                 | Test Environment | Ambient Climate & Rated Voltage                 |  |  |
| Transmit Output Power Data   Average Power Spectral Density (if required)   Peak-to-Average Ratio (if required)    Modulation Characteristics   Bandwidth   Emission Bandwidth (if required)    Band Edges Compliance    Band Edges Compliance   Emission Mask   Emission Mask    Tost Environment   Test Mode   Test Environment   Test Mode   Test Setup   Test Se |   | Averes Deves    | Test Setup       | Test Setup 1                                    |  |  |
| Output Power Data  Average Power, Spectral Density (if required)  Peak-to-Average Ratio (if required)  Peak-to-Average Ratio (if required)  Peak-to-Average Ratio (if required)  Peak-to-Average Ratio (if required)  Test Setup   |   |                 | RF Channels (TX) |   |  |  |
| Data   |   |                 | Test Mode        | LTE/TM1;LTE/TM2;                                |  |  |
| Average Power, Spectral Density (if required)  RF Channels (TX)  RF Channels (TX)  RF Channels (TX)  Test Mode  LTE/TM1;LTE/TM2;  Test Setup  Test Setup 1  RF Channels (TX)  RF Channels (TX)  RF Channels (TX)  Test Setup 1  RF Channels (TX)  Test Mode  LTE/TM1;LTE/TM2;  Test Setup 1  RF Channels (TX)  Test Setup 1  Test Setup 1  RF Channels (TX)  Test Setup 1  Test Setup 1  Test  |   |                 | Test Environment | Ambient Climate & Rated Voltage                 |  |  |
| RF Channels (TX)   high channel  | Data                                      | Average Power,  | Test Setup       | Test Setup 1                                    |  |  |
| Peak-to-Average Ratio (if required)  Test Environment Test Setup 1  RF Channels (TX) L, M, H (L= low channel, M= middle channel, H= high channel)  Test Mode LTE/TM1;LTE/TM2;  Test Setup Test Setup 1  RF Channels (TX) Ambient Climate & Rated Voltage  Test Setup 1  RF Channels (TX) L, M, H (L= low channel, M= middle channel, H= high channel)  Test Mode LTE/TM1;LTE/TM2;  Test Environment Ambient Climate & Rated Voltage  Test Setup Test Setup 1  Test Mode LTE/TM1;LTE/TM2;  Test Environment Ambient Climate & Rated Voltage  Test Setup Test Setup 1  RF Channels (TX) L, M, H (L= low channel, M= middle channel, H= high channel)  Test Mode LTE/TM1;LTE/TM2;  Test Environment Ambient Climate & Rated Voltage  Test Setup Test Setup 1  RF Channels (TX) L, M, H (L= low channel, M= middle channel, H= high channel)  Test Mode LTE/TM1;LTE/TM2;  Test Setup Test Setup 1  RF Channels (TX) L, M, H (L= low channel, M= middle channel, H= high channel)  Test Mode LTE/TM1;LTE/TM2;  Test Environment Ambient Climate & Rated Voltage  Test Setup Test Setup 1  RF Channels (TX) L, M, H (L= low channel, M= middle channel, H= high channel)  Test Mode LTE/TM1;LTE/TM2;  Test Environment Ambient Climate & Rated Voltage  Test Setup Test Setup 1  RF Channels (TX) L, H (L= low channel, H= high channel)  Test Setup Test Setup 1  RF Channels (TX) L, H (L= low channel, H= high channel)  Test Setup Test Setup 1  RF Channels (TX) L, H (L= low channel, H= high channel)  Test Setup Test Setup 1  RF Channels (TX) L, H (L= low channel, H= high channel)  Test Setup Test Setup 1  Test Setup Test Setup 1  RF Channels (TX) L, H (L= low channel, H= high channel)  Test Setup Test Setup 1  Test Setup Test Setup 1  Test Setup Test Setup 1  RF Channels (TX) L, H (L= low channel, H= high channel)  Test Setup Test Setup 1  Test Setup T |   |                 | RF Channels (TX) |   |  |  |
| Peak-to-Average Ratio (if required)  Test Setup  RF Channels (TX)  Test Mode  LTE/TM1;LTE/TM2;  Test Benvironment  Ambient Climate & Rated Voltage  Test Setup  RF Channels (TX)  Test Mode  LTE/TM1;LTE/TM2;  Test Setup  RF Channels (TX)  Test Mode  LTE/TM1;LTE/TM2;  Test Mode  LTE/TM1;LTE/TM2;  Test Environment  Ambient Climate & Rated Voltage  Test Setup  Test Setup  Test Setup 1  RF Channels (TX)  Test Setup 1  RF Channels (TX)  Test Mode  LTE/TM1;LTE/TM2;  Test Environment  Test Mode  LTE/TM1;LTE/TM2;  Test Environment  Ambient Climate & Rated Voltage  Test Setup 1  Test Setup 1  Test Setup 1  Test Setup 1  RF Channels (TX)  Test Setup 1  RF Channels (TX)  Test Setup 1  RF Channels (TX)  Test Mode  LTE/TM1;LTE/TM2;  Test Setup 1  Test Mode  LTE/TM1;LTE/TM2;  Test Setup 1  RF Channels (TX)  Test Setup 1  RF Channels (TX)  Test Setup 1  Test Setup 1  Test Setup 1  RF Channels (TX)  Test Setup 1  RF Channels (TX)  Test Setup 1  RF Channels (TX)  Test Setup 1              |   |                 | Test Mode        | LTE/TM1;LTE/TM2;                                |  |  |
| RF Channels (TX)   |   |                 | Test Environment | Ambient Climate & Rated Voltage                 |  |  |
| RF Channels (TX)   | Peak-to-Ave                               | rage Ratio      | Test Setup       | Test Setup 1                                    |  |  |
| Modulation Characteristics    Test Environment   |   | rage riano      | RF Channels (TX) |   |  |  |
| Test Setup   Test Setup 1  |   |                 | Test Mode        | LTE/TM1;LTE/TM2;                                |  |  |
| Ambient Climate & Rated Voltage  Test Mode  Docupied Bandwidth  Test Setup  Test Mode  LTE/TM1;LTE/TM2;  Test Invironment  Test Mode  LTE/TM1;LTE/TM2;  Test Environment  Test Setup  Test |   |                 | Test Environment | Ambient Climate & Rated Voltage                 |  |  |
| Bandwidth    RF Channels (TX)   M (M= middle channe )  | Madulation (                              | Sharaatariation | Test Setup       | Test Setup 1                                    |  |  |
| Bandwidth    Cocupied Bandwidth   Test Setup   Test Setup 1  | Modulation                                | Snaracteristics | RF Channels (TX) | M (M= middle channe )                           |  |  |
| Bandwidth    Test Setup   Test Setup 1   |   |                 | Test Mode        | LTE/TM1;LTE/TM2;                                |  |  |
| Bandwidth    RF Channels (TX)  |   |                 | Test Environment | Ambient Climate & Rated Voltage                 |  |  |
| Bandwidth  RF Channels (TX)  Test Mode  LTE/TM1;LTE/TM2;  Test Setup  RF Channels (TX)  Emission Bandwidth (if required)  RF Channels (TX)  Test Setup  RF Channels (TX)  Test Setup 1  RF Channels (TX)  Test Mode  LTE/TM1;LTE/TM2;  Test Mode  LTE/TM1;LTE/TM2;  Test Environment  Ambient Climate & Rated Voltage  Test Setup 1  RF Channels (TX)  Test Setup 1  Test Setup 1  RF Channels (TX)  Test Mode  LTE/TM1;LTE/TM2;  Test Mode  LTE/TM1;LTE/TM2;  Test Environment  Ambient Climate & Rated Voltage  Test Setup 1  RF Channels (TX)  Test Setup 1  Test Setup 1  Test Setup 1  Test Mode  LTE/TM1;LTE/TM2;  Test Environment  Ambient Climate & Rated Voltage  Test Setup 1  Test Mode  LTE/TM1;LTE/TM2;  Test Environment  Test Setup 1  |   | Occupied        | Test Setup       | Test Setup 1                                    |  |  |
| Bandwidth  Emission Bandwidth (if required)  Emission Bandwidth (if required)  Emission Bandwidth (if required)  Emission Bandwidth (if required)  Test Setup  Test Setup 1  L, M, H (L= low channel, M= middle channel, H= high channel)  Test Mode  LTE/TM1;LTE/TM2;  Test Setup  Test Setup 1  RF Channels (TX)  RF Channels (TX)  Test Setup 1  RF Channels (TX)  Test Mode  LTE/TM1;LTE/TM2;  Test Environment  Ambient Climate & Rated Voltage  Test Setup 1  Test Mode  LTE/TM1;LTE/TM2;  Test Setup 1  RF Channels (TX)  Test Setup 1  Test Setup 1  Test Setup 1  Test Setup 1  RF Channels (TX)  Test Setup 1  RF Channels (TX)  Test Setup 1  RF Channels (TX)  L, H (L= low channel, H= high channel)  Test Mode  LTE/TM1;LTE/TM2;  Test Setup 1   |   |                 | RF Channels (TX) |   |  |  |
| Emission Bandwidth (if required)  Band Edges Compliance  Emission Mask  Emission Bandwidth (if required)  Test Setup  Test Setup 1  RF Channels (TX)  Test Mode  LTE/TM1;LTE/TM2;  Test Setup 1  Ambient Climate & Rated Voltage thingh channel, H= high channel (TX) (Test Setup 1)  Test Setup Test Setup 1  Test Mode  LTE/TM1;LTE/TM2;  Test Setup 1  L, M, H (L= low channel, M= middle channel, H= high channel )  Test Mode  LTE/TM1;LTE/TM2;  Test Environment Ambient Climate & Rated Voltage  Test Setup Test Setup 1  Test Mode  LTE/TM1;LTE/TM2;  Test Setup 1  Test Mode LTE/TM1;LTE/TM2;  Test Environment Ambient Climate & Rated Voltage  Test Setup 1  | Dandwidth                                 |                 | Test Mode        | LTE/TM1;LTE/TM2;                                |  |  |
| Bandwidth (if required)  RF Channels (TX) Test Mode LTE/TM1;LTE/TM2;  Test Setup Test Setup Test Setup 1  RF Channels (TX) L, M, H (L= low channel, M= middle channel, H= high channel)  Test Setup 1  RF Channels (TX) Test Setup 1  RF Channels (TX) Test Mode LTE/TM1;LTE/TM2; Test Mode LTE/TM1;LTE/TM2; Test Setup 1  Test Setup 1  Test Setup Climate & Rated Voltage  Test Setup Test Setup 1  RF Channels (TX) L, H (L= low channel, M= middle channel, H= high channel)  Test Mode LTE/TM1;LTE/TM2; Test Setup 1  RF Channels (TX) L, H (L= low channel, H= high channel)  Test Mode LTE/TM1;LTE/TM2; Test Setup 1  | Dariuwiutii                               | Bandwidth       | Test Environment | Ambient Climate & Rated Voltage                 |  |  |
| RF Channels (TX)   |   |                 | Test Setup       | Test Setup 1                                    |  |  |
| Test Environment Ambient Climate & Rated Voltage  Test Setup Test Setup 1  RF Channels (TX) L, M, H (L= low channel, M= middle channel, H= high channel)  Test Mode LTE/TM1;LTE/TM2;  Test Environment Ambient Climate & Rated Voltage  Test Setup Test Setup 1  RF Channels (TX) L, H (L= low channel, H= high channel)  Test Mode LTE/TM1;LTE/TM2;  Test Mode LTE/TM1;LTE/TM2;  Test Mode LTE/TM1;LTE/TM2;  Test Environment Ambient Climate & Rated Voltage  Test Setup 1  Test Mode LTE/TM1;LTE/TM2;  Test Environment Ambient Climate & Rated Voltage   |   |                 | RF Channels (TX) |   |  |  |
| Test Setup Test Setup 1  RF Channels (TX) L, M, H (L= low channel, M= middle channel, H= high channel)  Test Mode LTE/TM1;LTE/TM2;  Test Environment Ambient Climate & Rated Voltage  Test Setup Test Setup 1  RF Channels (TX) L, H (L= low channel, H= high channel)  Test Mode LTE/TM1;LTE/TM2;  Test Mode LTE/TM1;LTE/TM2;  Test Mode LTE/TM1;LTE/TM2;  Test Environment Ambient Climate & Rated Voltage  Test Setup 1   |   |                 | Test Mode        | LTE/TM1;LTE/TM2;                                |  |  |
| Band Edges Compliance  RF Channels (TX)  Test Mode  LTE/TM1;LTE/TM2;  Test Environment  Ambient Climate & Rated Voltage  Test Setup  Test Setup 1  RF Channels (TX)  L, M, H (L= low channel, M= middle channel, H= high channel)  Test Setup 2  RF Channels (TX)  L, H (L= low channel, H= high channel)  Test Mode  LTE/TM1;LTE/TM2;  Test Environment  Ambient Climate & Rated Voltage  Test Setup 1  Test Setup 1  Test Setup 1  Test Setup 1  |   |                 | Test Environment | Ambient Climate & Rated Voltage                 |  |  |
| Emission Mask  Emission Mask  Test Environment Ambient Climate & Rated Voltage  Test Setup Test Setup 1  RF Channels (TX) L, H (L= low channel, H= high channel )  Test Mode LTE/TM1;LTE/TM2;  Test Mode LTE/TM1;LTE/TM2;  Test Environment Ambient Climate & Rated Voltage  Test Setup 1  Test Setup 1  Test Setup 1  Test Setup 1  |   |                 | Test Setup       | Test Setup 1                                    |  |  |
| Emission Mask  Test Environment Ambient Climate & Rated Voltage  Test Setup Test Setup 1  RF Channels (TX) L, H (L= low channel, H= high channel)  Test Mode LTE/TM1;LTE/TM2;  Test Environment Ambient Climate & Rated Voltage  Spurious Emission at Antenna  Test Setup 1  Test Setup 1  | Band Edges Compliance                     |                 | RF Channels (TX) |   |  |  |
| Test Setup 1  RF Channels (TX) L, H (L= low channel, H= high channel)  Test Mode LTE/TM1;LTE/TM2;  Test Environment Ambient Climate & Rated Voltage  Test Setup 1  Test Setup 1  |   |                 | Test Mode        | LTE/TM1;LTE/TM2;                                |  |  |
| RF Channels (TX) L, H (L= low channel, H= high channel )  Test Mode LTE/TM1;LTE/TM2;  Test Environment Ambient Climate & Rated Voltage  Spurious Emission at Antenna  Test Setup 1   | Emission Mask                             |                 | Test Environment | Ambient Climate & Rated Voltage                 |  |  |
| RF Channels (TX) L, H (L= low channel, H= high channel )  Test Mode LTE/TM1;LTE/TM2;  Test Environment Ambient Climate & Rated Voltage  Test Setup 1  Test Setup 1   |   |                 | Test Setup       | Test Setup 1                                    |  |  |
| Spurious Emission at Antenna Test Environment Ambient Climate & Rated Voltage  Test Setup 1  Test Setup 1  |   |                 | RF Channels (TX) | L, H (L= low channel, H= high channel)          |  |  |
| Spurious Emission at Antenna Tost Setup 1  |   |                 | Test Mode        | LTE/TM1;LTE/TM2;                                |  |  |
|  |   |                 | Test Environment | Ambient Climate & Rated Voltage                 |  |  |
|  | Spurious Emission at Antenna<br>Terminals |                 | Test Setup       | Test Setup 1                                    |  |  |
| RF Channels (TX) L,M, H (L= low channel, M= middle channel, H= high  |   |                 | RF Channels (TX) | L,M, H (L= low channel, M= middle channel, H= h |  |  |



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|                                      |                  | channel)  |
|--------------------------------------|------------------|---|
|                                      | Test Mode        | LTE/TM1.  |
|                                      | Test Environment | Ambient Climate & Rated Voltage   |
|                                      | Test Setup       | Test Setup 2  |
| Field Strength of Spurious Radiation | Test Mode        | LTE/TM1; NOTE: If applicable, the EUT conf. that has maximum power density (based on the equivalent power level) is selected. |
|                                      | RF Channels (TX) | L, M, H (L= low channel, M= middle channel, H= high channel)  |
|                                      | Test Env.        | (1) -30 °C to +50 °C with step 10 °C at Rated Voltage;  |
|                                      | Test Ellv.       | (2) VL, VN and VH of Rated Voltage at Ambient Climate.  |
| Frequency Stability                  | Test Setup       | Test Setup 4  |
|                                      | RF Channels (TX) | L, M, H (L= low channel, M= middle channel, H= high channel)  |
|                                      | Test Mode        | LTE/TM1;LTE/TM2;  |



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### 7 Main Test Instruments

|      | RE in Chamber                        |  |           |               |                               |                                  |
|------|--------------------------------------|--|-----------|---------------|-------------------------------|----------------------------------|
| Item | Test Equipment                       | Manufacturer                             | Model No. | Inventory No. | Cal. date<br>(yyyy-mm-<br>dd) | Cal.Due date<br>(yyyy-mm-<br>dd) |
| 1    | 3m Semi-Anechoic<br>Chamber          | ETS-LINDGREN                             | N/A       | SEM001-01     | 2017-05-10                    | 2018-05-10                       |
| 2    | EMI Test Receiver                    | Agilent<br>Technologies                  | N9038A    | SEM004-05     | 2017-10-09                    | 2018-10-09                       |
| 3    | BiConiLog Antenna<br>(26-3000MHz)    | ETS-LINDGREN                             | 3142C     | SEM003-02     | 201711-15                     | 2020-11-15                       |
| 4    | Double-ridged horn<br>(1-18GHz)      | ETS-LINDGREN                             | 3117      | SEM003-11     | 2015-10-17                    | 2018-10-17                       |
| 5    | Horn Antenna (18-<br>26GHz)          | ETS-LINDGREN                             | 3160      | SEM003-12     | 2017-11-24                    | 2020-11-24                       |
| 6    | Pre-amplifier (0.1-<br>1300MHz)      | Agilent<br>Technologies                  | 8447D     | SEM005-01     | 2018/2/14                     | 2019/2/13                        |
| 7    | Pre-Amplifier (0.1-<br>26.5GHz)      | Compliance<br>Directions<br>Systems Inc. | PAP-0126  | SEM004-10     | 2017-10-17                    | 2018-10-17                       |
| 8    | Band filter                          | Amindeon                                 | 82346     | SEM023-01     | N/A                           | N/A                              |
| 9    | Universal radio communication tester | Rohde &Schwarz                           | CMU200    | SEM010-01     | 2017-10-09                    | 2018-10-09                       |
| 10   | Universal radio communication tester | Rohde &Schwarz                           | CMW500    | SEM010-03     | 2017-10-23                    | 2018-10-23                       |
| 11   | DC Power Supply                      | Zhao Xin                                 | RXN-305D  | SEM011-02     | 2017-10-09                    | 2018-10-09                       |
| 12   | BiConiLog Antenna<br>(30MHz-3GHz)    | Schwarzbeck                              | VULB9163  | SEM003-05     | 2015-10-17                    | 2018-10-17                       |
| 13   | Horn Antenna<br>(800MHz-18GHz)       | Rohde &Schwarz                           | HF907     | SEM003-06     | 2015-06-14                    | 2018-06-14                       |

|      | RE in Chamber                         |                         |           |               |                        |                              |
|------|---------------------------------------|-------------------------|-----------|---------------|------------------------|------------------------------|
| Item | Test Equipment                        | Manufacturer            | Model No. | Inventory No. | Cal. Date (yyyy-mm-dd) | Cal. Due date<br>(yyyy-mm-dd |
| 1    | 10m Semi-Anechoic<br>Chamber          | SAEMC                   | FSAC1018  | SEM001-03     | 2017-05-10             | 2018-05-10                   |
| 2    | EMI Test Receiver<br>(9k-7GHz)        | Rohde & Schwarz         | ESR       | SEM004-03     | 2018/2/14              | 2019/2/13                    |
| 3    | Trilog-Broadband<br>Antenna(30M-1GHz) | Schwarzbeck             | VULB9168  | SEM003-18     | 2016-06-29             | 2019-06-29                   |
| 4    | Pre-amplifier                         | Sonoma<br>Instrument Co | 310N      | SEM005-03     | 2017-07-06             | 2018-07-06                   |
| 5    | .Loop Antenna                         | ETS-Lindgren            | 6502      | SEM003-08     | 2015-08-14             | 2018-08-14                   |



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|      | RF connected test                                |                                |           |               |                  |                  |
|------|--|--------------------------------|-----------|---------------|------------------|------------------|
|      |  |                                |           |               | Cal. date        | Cal.Due date     |
| Item | Test Equipment                                   | Manufacturer                   | Model No. | Inventory No. | (yyyy-mm-<br>dd) | (yyyy-mm-<br>dd) |
| 1    | Signal Analyzer                                  | Rohde<br>Schwarz               | FSV       | W005-02       | 2018-03-13       | 2019-03-13       |
| 2    | Barometer  | ChangChun                      | DYM3      | SEL0088       | 2017-05-24       | 2018-05-24       |
| 3    | Dual Output Mobile<br>Communication DC<br>Source | Agilent<br>Technologies<br>Inc | 66319D    | W009-02       | 2017-07-23       | 2018-07-23       |
| 4    | Digital Multimeter                               | Fluke                          | 15B+      | W055-01       | 2018-03-19       | 2019-03-19       |
| 5    | Wideband Radio<br>Communication Tester           | Rohde &<br>Schwarz             | CMW500    | W005-02       | 2018-03-13       | 2019-03-13       |
| 6    | Wideband Radio CommunicationTester               | Rohde &<br>Schwarz             | CMW500    | W005-02       | 2018-03-13       | 2019-03-13       |

## 8 Measurement Uncertainty

For a 95% confidence level (k = 2), the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 as following:

| Test Item                     | Extended Uncertainty     | Data                        |  |
|-------------------------------|--------------------------|-----------------------------|--|
| Transmit Output Power Data    | Power [dBm]              | U = 0.37 dB                 |  |
| Bandwidth                     | Magnitude [%]            | U = 0.2%                    |  |
| Band Edge Compliance          | Disturbance Power [dBm]  | U = 2.0 dB                  |  |
| Spurious Emissions, Conducted | Disturbance Power [dBm]  | U = 2.0 dB                  |  |
|                               |                          | For 3 m Chamber:            |  |
|                               |                          | U = 4.5 dB (30 MHz to 1GHz) |  |
| Field Strength of Spurious    | ERP [dBm]                | U = 3.3 dB (above 1 GHz)    |  |
| Radiation                     | ENF [dBiii]              | For 10 m Chamber:           |  |
|                               |                          | U = 4.5 dB (30 MHz to 1GHz) |  |
|                               |                          | U = 3.2 dB (above 1 GHz)    |  |
| Frequency Stability           | Frequency Accuracy [ppm] | U = 0.24 ppm                |  |

## 9 Photographs - EUT Constructional Details

Refer to Appendix A - Photographs of EUT Constructional Details for SZEM1804002898RG

The End